

<b>Notice of References Cited</b>	Application/Control No. 10/791,526	Applicant(s)/Patent Under Reexamination TAKASHIMA ET AL.	
	Examiner Nguyen N Hanh	Art Unit 2834	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,329,735	12-2001	Tanaka et al.	310/239
	B	US-4,501,983	02-1985	Schmider, Fritz	310/113
	C	US-5,942,822	08-1999	Iwata et al.	310/71
	D	US-5,280,207	01-1994	Nishmura, Hideki	310/67R
	E	US-3,924,147	12-1975	Tarnow et al.	310/68R
	F	US-5,089,735	02-1992	Sawaguchi et al.	310/88
	G	US-5,610,456	03-1997	Wille et al.	310/58
	H	US-6,734,589	05-2004	Kogure et al.	310/89
	I	US-3,745,393	07-1973	Spors, James A.	310/239
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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